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Metallic communication cable test methods – Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic screening measurements



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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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METALLIC COMMUNICATION CABLE TEST METHODS –

Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic screening measurements

FOREWORD

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This consolidated version of the official IEC Standard and its amendment(s) has been prepared for user convenience. The IEC Central Office guarantees accuracy of its technical content.

IEC TS 62153-4-1 edition 1.1 contains the first edition (2014-01) [documents 46/465/DTS and 46/492/RVC] and its amendment 1 (2020-05) [documents 46/726/DTS and 46/748/RVDTS].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.

The main task of IEC technical committees is to prepare International Standards. In exceptional circumstances, a technical committee may propose the publication of a technical specification when

- the required support cannot be obtained for the publication of an International Standard, despite repeated efforts, or
- the subject is still under technical development or where, for any other reason, there is the future but no immediate possibility of an agreement on an International Standard.

Technical specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC TS 62153-4-1, which is a technical specification, has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This first edition of technical specification IEC TS 62153-4-1 constitutes a technical revision. This edition includes the following significant technical changes with respect to IEC TR 62153-4-1:

a) comparison of the frequency response of different triaxial test set-ups to measure the transfer impedance of cable screens;
b) background of the shielded screening attenuation test method (IEC 62153-4-4);
c) background of the shielded screening attenuation test method for measuring the screening effectiveness of feed-throughs and electromagnetic gaskets (IEC 62153-4-10);
d) background of the shielded screening attenuation test method for measuring the screening effectiveness of RF connectors and assemblies (IEC 62153-4-7).

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62153 series, under the general title: *Metallic communication cable test methods*, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

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METALLIC COMMUNICATION CABLE TEST METHODS –

Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic (EMC) screening measurements

1 Scope

This part of IEC 62153 deals with screening measurements. Screening (or shielding) is one basic way of achieving electromagnetic compatibility (EMC). However, a confusingly large number of methods and concepts is available to test for the screening quality of cables and related components, and for defining their quality. This technical specification gives a brief introduction to basic concepts and terms trying to reveal the common features of apparently different test methods. It is intended to assist in correct interpretation of test data, and in the better understanding of screening (or shielding) and related specifications and standards.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60096-1:1986, *Radio-frequency cables – Part 1: General requirements and measuring methods*[1]

IEC 60096-4-1, *Radio-frequency cables – Part 4: Specification for superscreened cables – Section 1: General requirements and test methods*[1]

IEC 60169-1-3, *Radio-frequency connectors - Part 1: General requirements and measuring methods - Section Three: Electrical tests and measuring procedures: Screening effectiveness*

IEC 61196-1:2005, *Coaxial communication cables - Part 1: Generic specification - General, definitions and requirements*

IEC 61726, *Cable assemblies, cables, connectors and passive microwave components - Screening attenuation measurement by the reverberation chamber method*

IEC 62153-4-2, *Metallic communication cable test methods - Part 4-2: Electromagnetic compatibility (EMC) - Screening and coupling attenuation - Injection clamp method*

IEC 62153-4-3, *Metallic communication cable test methods - Part 4-3: Electromagnetic compatibility (EMC) - Surface transfer impedance - Triaxial method*

IEC 62153-4-4, *Metallic communication cable test methods - Part 4-4: Electromagnetic compatibility (EMC) - Shielded screening attenuation, test method for measuring of the screening attenuation as up to and above 3 GHz*

IEC 62153-4-5, *Metallic communication cables test methods - Part 4-5: Electromagnetic compatibility (EMC) - Coupling or screening attenuation - Absorbing clamp method*

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[1] This publication has been withdrawn.

IEC 62153-4-6, *Metallic communication cable test methods - Part 4-6: Electromagnetic compatibility (EMC) - Surface transfer impedance - Line injection method*

IEC 62153-4-7, *Metallic communication cable test methods - Part 4-7: Electromagnetic compatibility (EMC) - Test method for measuring the transfer impedance and the screening - or the coupling attenuation - Tube in tube method*

IEC 62153-4-9, *Metallic communication cable test methods – Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method*

IEC 62153-4-10, *Metallic communication cable test methods - Part 4-10: Electromagnetic compatibility (EMC) - Shielded screening attenuation test method for measuring the screening effectiveness of feed-throughs and electromagnetic gaskets double coaxial method*

IEC/TR 62152:2009, *Transmission properties of cascaded two-ports or quadripols – Background of terms and definitions*

EN 50289-1-6: 2002*, Communication cables – Specifications for test methods Part 1-6: Electrical test methods – Electromagnetic performance*

CISPR 25*, Vehicles, boats and internal combustion engines – Radio disturbance characteristics – Limits and methods of measurement for the protection of on-board receivers*

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

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METALLIC COMMUNICATION CABLE TEST METHODS –

Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic screening measurements

FOREWORD

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This consolidated version of the official IEC Standard and its amendment(s) has been prepared for user convenience. The IEC Central Office guarantees accuracy of its technical content.

IEC TS 62153-4-1 edition 1.1 contains the first edition (2014-01) [documents 46/465/DTS and 46/492/RVC] and its amendment 1 (2020-05) [documents 46/726/DTS and 46/748/RVDTS].

This Final version does not show where the technical content is modified by amendment 1. A separate Redline version with all changes highlighted is available in this publication.

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Technical specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC TS 62153-4-1, which is a technical specification, has been prepared by IEC technical committee 46: Cables, wires, waveguides, R.F. connectors, R.F. and microwave passive components and accessories.

This first edition of technical specification IEC TS 62153-4-1 constitutes a technical revision. This edition includes the following significant technical changes with respect to IEC TR 62153-4-1:

a) comparison of the frequency response of different triaxial test set-ups to measure the transfer impedance of cable screens;
b) background of the shielded screening attenuation test method (IEC 62153-4-4);
c) background of the shielded screening attenuation test method for measuring the screening effectiveness of feed-throughs and electromagnetic gaskets (IEC 62153-4-10);
d) background of the shielded screening attenuation test method for measuring the screening effectiveness of RF connectors and assemblies (IEC 62153-4-7).

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts of the IEC 62153 series, under the general title: *Metallic communication cable test methods*, can be found on the IEC website.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

METALLIC COMMUNICATION CABLE TEST METHODS –

Part 4-1: Electromagnetic compatibility (EMC) – Introduction to electromagnetic (EMC) screening measurements

1 Scope

This part of IEC 62153 deals with screening measurements. Screening (or shielding) is one basic way of achieving electromagnetic compatibility (EMC). However, a confusingly large number of methods and concepts is available to test for the screening quality of cables and related components, and for defining their quality. This technical specification gives a brief introduction to basic concepts and terms trying to reveal the common features of apparently different test methods. It is intended to assist in correct interpretation of test data, and in the better understanding of screening (or shielding) and related specifications and standards.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60096-1:1986, *Radio-frequency cables – Part 1: General requirements and measuring methods*[1]

IEC 60096-4-1, *Radio-frequency cables – Part 4: Specification for superscreened cables – Section 1: General requirements and test methods*[1]

IEC 60169-1-3, *Radio-frequency connectors - Part 1: General requirements and measuring methods - Section Three: Electrical tests and measuring procedures: Screening effectiveness*

IEC 61196-1:2005, *Coaxial communication cables - Part 1: Generic specification - General, definitions and requirements*

IEC 61726, *Cable assemblies, cables, connectors and passive microwave components - Screening attenuation measurement by the reverberation chamber method*

IEC 62153-4-2, *Metallic communication cable test methods - Part 4-2: Electromagnetic compatibility (EMC) - Screening and coupling attenuation - Injection clamp method*

IEC 62153-4-3, *Metallic communication cable test methods - Part 4-3: Electromagnetic compatibility (EMC) - Surface transfer impedance - Triaxial method*

IEC 62153-4-4, *Metallic communication cable test methods - Part 4-4: Electromagnetic compatibility (EMC) - Shielded screening attenuation, test method for measuring of the screening attenuation as up to and above 3 GHz*

IEC 62153-4-5, *Metallic communication cables test methods - Part 4-5: Electromagnetic compatibility (EMC) - Coupling or screening attenuation - Absorbing clamp method*

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[1] This publication has been withdrawn.

IEC 62153-4-6, *Metallic communication cable test methods - Part 4-6: Electromagnetic compatibility (EMC) - Surface transfer impedance - Line injection method*

IEC 62153-4-7, *Metallic communication cable test methods - Part 4-7: Electromagnetic compatibility (EMC) - Test method for measuring the transfer impedance and the screening - or the coupling attenuation - Tube in tube method*

IEC 62153-4-9, *Metallic communication cable test methods – Part 4-9: Electromagnetic compatibility (EMC) – Coupling attenuation of screened balanced cables, triaxial method*

IEC 62153-4-10, *Metallic communication cable test methods - Part 4-10: Electromagnetic compatibility (EMC) - Shielded screening attenuation test method for measuring the screening effectiveness of feed-throughs and electromagnetic gaskets double coaxial method*

IEC/TR 62152:2009, *Transmission properties of cascaded two-ports or quadripols – Background of terms and definitions*

EN 50289-1-6: 2002*, Communication cables – Specifications for test methods Part 1-6: Electrical test methods – Electromagnetic performance*

CISPR 25*, Vehicles, boats and internal combustion engines – Radio disturbance characteristics – Limits and methods of measurement for the protection of on-board receivers*